

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YU ET AL.	
		Examiner Andrew Schechter	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0114347	06-2004	Leu et al.	362/031
	B	US-6,767,105	07-2004	Nakahashi et al.	362/27
	C	US-2002/0036729	03-2002	Ohkawa, Shingo	349/65
	D	US-5,926,033	07-1999	Saigo et al.	326/31
	E	US-5,317,430	05-1994	Uratani, Shinichi	349/65
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.